

LCR808

Standard 8A SCRs

$I_{T(AV)}$	8 A
V_{DRM} / V_{RRM}	800 V
I_{GT}	15 mA
T_J	-40 °C to +125 °C

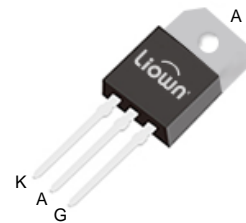
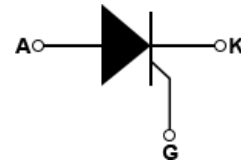
Features

- On-state RMS current, $I_{T(RMS)}$ 12A
- Repetitive peak off-state voltage, V_{DRM} and V_{RRM} 800V
- Triggering gate current, I_{GT} : 15 mA

Description

The standard 12A SCR series is suitable to fit all modes of control, found in applications such as overvoltage crowbar protection, motor control circuits in power tools and kitchen aids, inrush current limiting circuits, capacitive discharge ignition and voltage regulation circuits.

Available in through-hole or surface-mount packages, they provide an optimized performance in a limited space.



Absolute ratings (limiting values)

Symbol	Parameter		Value	Unit	
$I_{T(RMS)}$	On-state RMS current (180° conduction angle)	TO-220AB ins. D ² PAK DPAK	12	A	
$I_{T(AV)}$	Average on-state current (180° conduction angle)	IPAK	8		
I_{TSM}	Non repetitive surge peak on-state current	$t_p = 8.3$ ms	$T_j = 25$ °C	120	
		$t_p = 10$ ms		110	
I^2t	I^2t value for fusing		$T_j = 25$ °C	60	A ² S
di/dt	Critical rate of rise of on-state current $I_G = 2 \times I_{GT}$, $t_r \leq 100$ ns	F = 60 Hz	$T_j = 125$ °C	50	A/ μ s
I_{GM}	Peak gate current	$t_p = 20$ μ s	$T_j = 125$ °C	4	A
$P_{G(AV)}$	Average gate power dissipation		$T_j = 125$ °C	1	W
T_{stg} T_j	Storage junction temperature range Operating junction temperature range			- 40 to + 150 - 40 to + 125	°C
V_{RGM}	Maximum peak reverse gate voltage			5	V

Standard electrical characteristics ($T_j = 25\text{ }^\circ\text{C}$, unless otherwise specified)

Symbol	Test conditions							Unit
I_{GT}	$V_D = 12\text{ V}, R_L = 33\ \Omega$		Min.	2				mA
			Max.	15				
V_{GT}			Max.	1.3				V
V_{GD}	$V_D = V_{DRM}, R_L = 3.3\text{ k}\Omega$	$T_j = 125\text{ }^\circ\text{C}$	Min.	0.2				V
I_H	$I_T = 500\text{ mA}$, gate open		Max.	40	30	15	30	mA
I_L	$I_G = 1.2 I_{GT}$		Max.	80	60	30	60	mA
dV/dt	$V_D = 67\% V_{DRM}$, gate open	$T_j = 125\text{ }^\circ\text{C}$	Min.	200		40	200	V/ μs
V_{TM}	$I_{TM} = 24\text{ A}$	$t_p = 380\ \mu\text{s}$	$T_j = 25\text{ }^\circ\text{C}$	Max.	1.35			V
V_{to}	Threshold voltage		$T_j = 125\text{ }^\circ\text{C}$	Max.	0.85			V
R_d	Dynamic resistance		$T_j = 125\text{ }^\circ\text{C}$	Max.	30			m Ω
I_{DRM} I_{RRM}	$V = V = V = V$		$T_j = 25\text{ }^\circ\text{C}$	Max.	5			μA
			$T_j = 125\text{ }^\circ\text{C}$		2			mA

Symbol	Parameter		Value	Unit
$R_{th(j-c)}$	Junction to case (DC)	D ² PAK, DPAK, IPAK, TO-220AB	1.3	$^\circ\text{C/W}$
$R_{th(j-a)}$	Junction to ambient (DC)	$S^{(1)} = 0.5\text{ cm}^2$	DPAK	70
		$S^{(1)} = 1.0\text{ cm}^2$	D ² PAK	45
			IPAK	100
			TO-220AB	60

Figure 1. Maximum average power dissipation versus average on-state current

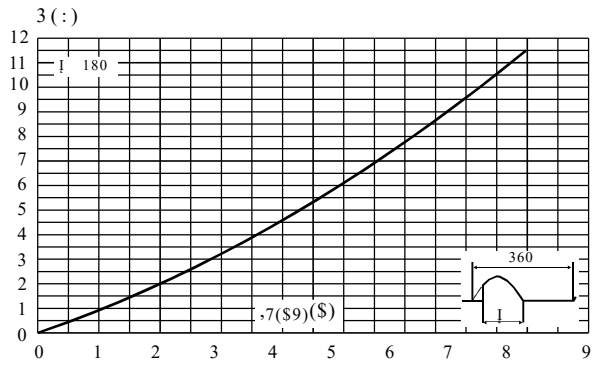


Figure 2. Average and DC on-state current versus case temperature

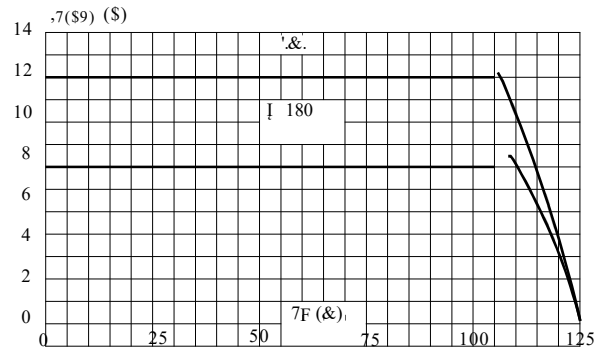


Figure 3. Average and DC on-state current versus ambient temperature (DPAK, D²PAK)

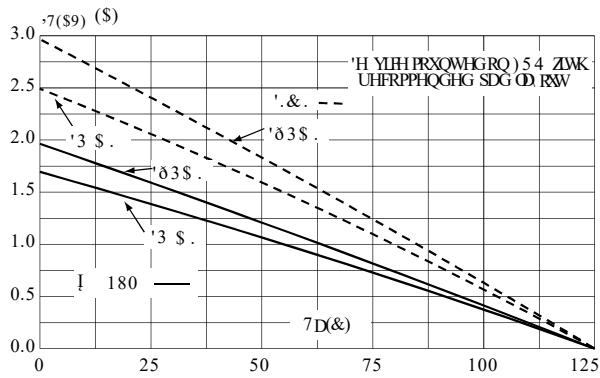


Figure 4. Relative variation of thermal impedance junction to case versus pulse duration

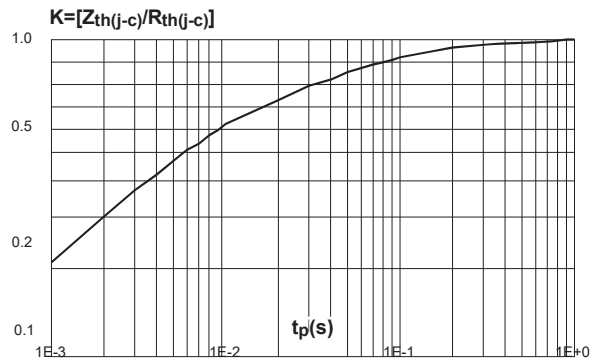


Figure 5. Relative variation of thermal impedance junction to ambient versus pulse duration

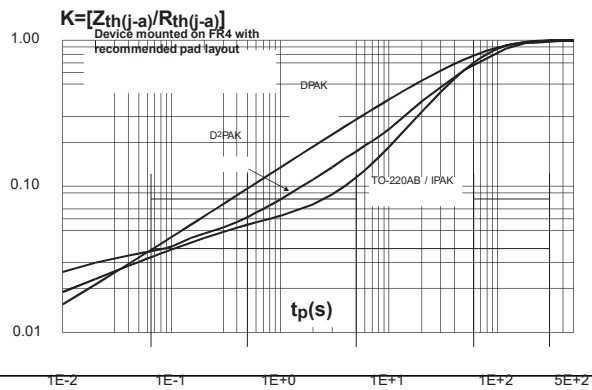


Figure 6. Relative variation of gate trigger, latching and holding current versus junction temperature

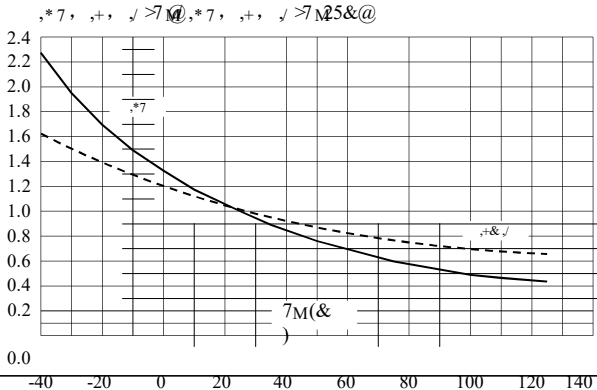


Figure 7. Surge peak on-state current versus number of cycles

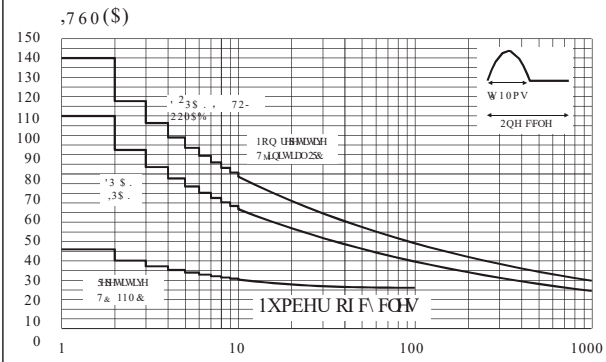


Figure 8. Non repetitive surge peak on-state current for a sinusoidal pulse with width $t_p < 10$ ms

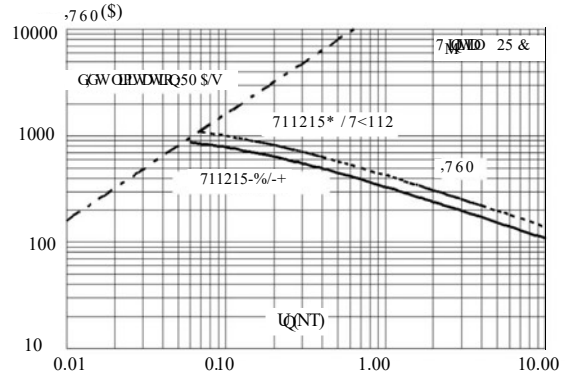


Figure 9. On-state characteristics (maximum values)

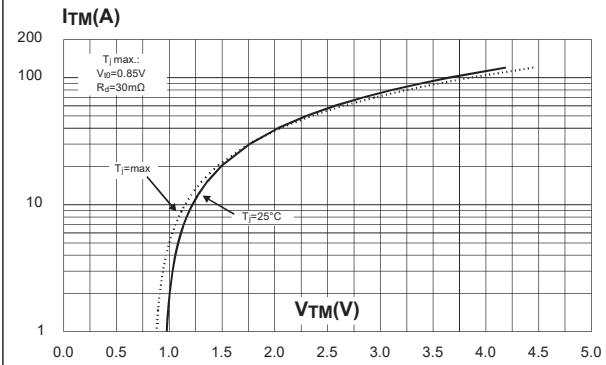


Figure 10. Thermal resistance junction to ambient versus copper surface under tab (DPAK and D²PAK)

